

Search Notes

Application/Control No.

10/731,517

Examiner

Eugene Lee

Applicant(s)/Patent under
Reexamination

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Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
257	324,311	2/14/2007	EL
257	317	2/14/2007	EL
257	e27.078	2/14/2007	EL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
257	324,311	2/14/2007	EL
257	317	2/14/2007	EL
257	e27.078	2/14/2007	EL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
searched EAST, USPAT, JPO, EPO	2/14/2007	EL